

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/775,254	IWATA ET AL.
	Examiner	Art Unit
	Tan T. Nguyen	2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	185.05	9/15/2006	TNT
365	185.17	9/15/2006	TNT
365	185.21	9/15/2006	TNT